

Semi-Supervised Classification

Classification Maximum Likelihood Approach

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Introduction

Introduction

- Semi-supervised machine learning

- ▶ Supervised learning : Infers a function from labeled training data

$$\{(y_i, x_i) : i = 1, \dots, n\}$$

- ▶ Unsupervised learning : Infers a function from unlabeled data

$$\{x_i : i = 1, \dots, n\}$$

- ▶ Semi-supervised learning : Learn by using both labeled and unlabeled data $\{(y_1, x_1), \dots, (y_n, x_n), x_{n+1}, \dots, x_m\}$

Introduction

- Semi-supervised classification methods

- ▶ Co-training : [1] Blum et al.(1998)
- ▶ CEM-algorithm : [3] Celeux, Govaert (1992)
- ▶ Transductive Support Vector Machine : [10] Joachims, Thorsten (1999)
- ▶ Graph-Based Method : [5] Scholkopf et al. (2006)

Classification Maximum Likelihood Criteria

Classification Maximum Likelihood Criteria

- Clustering methods based on maximum likelihood

- ▶ Let $x = (x_1, \dots, x_n)'$ be a given sample, $z_i = (z_{i1}, \dots, z_{iK})$ be a vector of class indicators : $z_{ik} = 1$ if x_i is from class k and $z_{ik} = 0$ otherwise.
- ▶ Then, x is a sample from the following mixture densities(parametric)

$$f(x) = \sum_{k=1}^K \lambda_k f(x, \theta_k)$$

$\lambda_k \in (0, 1)$ are the mixing weights ($k = 1, \dots, K$), and $\sum_k \lambda_k = 1$.

- ▶ λ_k, θ_k can be chosen by maximizing following log-likelihood generally using EM-algorithm [8] Dempster (1977))

$$L = \log \prod_{i=1}^n \sum_{k=1}^K \lambda_k f(x_i, \theta_k)$$

Classification Maximum Likelihood Criteria

- Clustering methods based on maximum likelihood : EM-algorithm

Suppose that $z = (z_1, \dots, z_n)$ is unobserved, and the initial value of parameters $\theta^{(0)}$ is given.

► E-step

$$Q(\theta|\theta^{(q)}) = E_{z|x, \theta^{(q)}} \log L(\theta; x, z) = \sum_z \log L(\theta; x, z) P(z|x, \theta^{(q)})$$

► M-step

$$\theta^{(q+1)} = \arg \max_{\theta} Q(\theta|\theta^{(q)})$$

F.O.C.

$$\frac{\partial Q(\theta|\theta^{(q)})}{\partial \theta} = \sum_z \frac{\partial \log L(\theta; x, z)}{\partial \theta} P(z|x, \theta^{(q)}) = 0$$

Classification Maximum Likelihood Criteria

- Clustering methods based on maximum likelihood : EM-algorithm

Example) [11] Lee, Porter (1984)

$$\begin{aligned}\ln L(\theta, \lambda, p_{11}, p_{01}) &= \sum_{t=1}^T w_t \ln (f_1(y_t)p_{11}\lambda + f_2(y_t)p_{01}(1 - \lambda)) \\ &\quad + (1 - w_t) \ln (f_1(y_t)(1 - p_{11})\lambda + f_2(y_t)(1 - p_{01})(1 - \lambda))\end{aligned}$$

► F.O.C. w.r.t. θ

$$\frac{\partial \ln L}{\partial \theta} = \sum_{t=1}^T \left[P(1|y_t, w_t) \frac{\partial \ln f_1(y_t)}{\partial \theta} + P(0|y_t, w_t) \frac{\partial \ln f_2(y_t)}{\partial \theta} \right] = 0$$

Classification Maximum Likelihood Criteria

- Clustering methods based on maximum likelihood : EM-algorithm

Theorem. $L(\theta; x, z) = f(x, z|\theta)$ increases as $Q(\theta|\theta^{(q)})$ increases.

Proof.

Since $f(x, z|\theta) = f(x|\theta)P(z|x, \theta)$, we have

$$\begin{aligned}\log f(x|\theta) &= \sum_z P(z|x, \theta^{(q)}) \log f(x, z|\theta) - \sum_z P(z|x, \theta^{(q)}) \log P(z|x, \theta) \\ &= Q(\theta|\theta^{(q)}) + H(\theta|\theta^{(q)})\end{aligned}$$

and

$$\begin{aligned}\log f(x|\theta) - \log f(x|\theta^{(q)}) &= Q(\theta|\theta^{(q)}) - Q(\theta^{(q)}|\theta^{(q)}) + H(\theta|\theta^{(q)}) - H(\theta^{(q)}|\theta^{(q)}) \\ &\geq Q(\theta|\theta^{(q)}) - Q(\theta^{(q)}|\theta^{(q)})\end{aligned}$$

by Gibbs' inequality. □

Classification Maximum Likelihood Criteria

- Classification maximum likelihood approach

- Let $\lambda = (\lambda_1, \dots, \lambda_K)$. The CML criterion* is defined by

$$C(z, \lambda, \theta) = \sum_{k=1}^K \sum_{i=1}^n z_{ik} \log \lambda_k f(x_i, \theta_k)$$

- In the CML approach, z, λ, θ are chosen by maximizing CML criterion.

Classification Maximum Likelihood Criteria

- Classification maximum likelihood approach

- For example, when there are two classes,

$$C(z, \lambda, \theta) = \sum_{i=1}^n z_i \log \lambda_1 f(x_i, \theta_1) + (1 - z_i) \log(1 - \lambda_1) f(x_i, \theta_2)$$

F.O.Cs are

$$(\lambda_1) : \sum_{i=1}^n \left(\frac{z_i}{\lambda_1} - \frac{1 - z_i}{1 - \lambda_1} \right) = 0$$

$$\Rightarrow \hat{\lambda}_1 = \frac{1}{n} \sum_{i=1}^n z_i$$

$$(z_i) : \log \lambda_1 f(x_i, \theta_1) = \log(1 - \lambda_1) f(x_i, \theta_2)$$

$$\Rightarrow z_i = I(\lambda_1 f(x_i, \theta_1) > (1 - \lambda_1) f(x_i, \theta_2))$$

$$(\theta_1) : \sum_{i=1}^n z_i \frac{\partial \log f(x_i, \theta_1)}{\partial \theta_1}$$

*[14] Scott, Symons (1971)

Classification Maximum Likelihood Criteria

- Classification maximum likelihood approach : CEM-algorithm

Let $\theta^{(0)}, \lambda^{(0)}$ be given. Then, in the q^{th} iteration,

► E-step : Expectation

Calculate posterior probabilities that x_i belongs to class k as

$$t_k^{(q)}(x_i) = \frac{\lambda_k^{(q)} f(x_i, \theta_k^{(q)})}{\sum_{k=1}^K \lambda_k^{(q)} f(x_i, \theta_k^{(q)})}$$

► C-step : Classification

Assign each x_i to the cluster which provides the maximum $t_k^{(q)}(x_i)$:

$$z_{ik}^{(q)} = I \left(k = \inf \left\{ m : t_m^{(q)}(x_i) \geq t_l^{(q)}(x_i) \quad \forall l = 1, \dots, K \right\} \right)$$

► M-step : Maximization

Calculate $\lambda_k^{(q+1)} = \frac{1}{n} \sum_{i=1}^n z_{ik}^{(q)}$, and obtain $\theta^{(q+1)}$ by maximizing CML criterion given $z_{ik}^{(q)}, \lambda_k^{(q+1)}$.

Classification Maximum Likelihood Criteria

- Classification maximum likelihood approach : CEM-algorithm

Theorem.[†] Any sequence $\{z^{(q)}, \lambda^{(q)}, \theta^{(q)}\}$ of the CEM algorithm increases the CML criterion and the sequence $\{C(z^{(q)}, \lambda^{(q)}, \theta^{(q)})\}$ converges to a stationary value. Moreover, if the mixture estimates of the parameters are well-defined, the sequence $\{z^{(q)}, \lambda^{(q)}, \theta^{(q)}\}$ converges to a stationary position.

Classification Maximum Likelihood Criteria

- Classification maximum likelihood approach : CEM-algorithm

Proof.

- $C(z, \lambda, \theta)$ is increasing given z by M-step. i.e.,

$$C(z^{(q)}, \lambda^{(q+1)}, \theta^{(q+1)}) \geq C(z^{(q)}, \lambda^{(q)}, \theta^{(q)})$$

- We have also $C(z^{(q+1)}, \lambda^{(q+1)}, \theta^{(q+1)}) \geq C(z^{(q)}, \lambda^{(q+1)}, \theta^{(q+1)})$ since

$$\begin{aligned} z_{ik}^{(q+1)} = 1 &\Leftrightarrow t_k^{(q+1)}(x_i) \geq t_l^{(q+1)}(x_i) \quad \forall k \neq l \\ &\Leftrightarrow \lambda_k^{(q+1)} f(x_i, \theta_k^{(q+1)}) \geq \lambda_l^{(q+1)} f(x_i, \theta_l^{(q+1)}) \\ &\Rightarrow C(z^{(q+1)}, \lambda^{(q+1)}, \theta^{(q+1)}) \geq C(z^{(q)}, \lambda^{(q+1)}, \theta^{(q+1)}) \end{aligned}$$

- Since $K < \infty$, the increasing sequence $\{C(z^{(q)}, \lambda^{(q)}, \theta^{(q)})\}$ converges.

Hence, if λ, θ are well-defined, the sequence $\{z^{(q)}, \lambda^{(q)}, \theta^{(q)}\}$ also converges.

[†][3] Celeux, Govaert (1992) proposition 2

Semi-supervised CEM-algorithm

Semi-supervised CEM-algorithm

- CEM-algorithm using labeled data together with unlabeled data

- ▶ [13] McLachlan (1992) extended CML-CEM algorithm to the case where both labeled and unlabeled data are used for learning.
- ▶ Let $x_l = \{(x_i, t_{ik}) : i = 1, \dots, m\}$ be the labeled data, and $x_u = \{x_i : i = m + 1, \dots, n\}$ be the unlabeled data.
- ▶ The CML criterion in this case can be written as

$$L_c = \sum_{i=1}^m \sum_{k=1}^K t_{ik} \log f(x_i, \theta_k) + \sum_{i=m+1}^n \sum_{k=1}^K z_{ik} \log f(x_i, \theta_k)$$

L_c can be maximized by applying C-step to the unlabeled part.

Semi-supervised CEM-algorithm

- CEM-algorithm using misclassified label

- ▶ In practice, there are also classification error in the training data.
- ▶ Methods and result of Learning with imperfect labeled training data is proposed by [6] Chittineni (1980) [7] Chittineni (1981)
- ▶ Let \hat{c} be the assigned class of x , and c is underlying true class of x .
- ▶ Density function when x_i belongs to class k is

$$\begin{aligned} f(x_i, \hat{c} = k) &= \sum_{l=1}^K f(x_i, \hat{c} = k, c = l) \\ &= \sum_{l=1}^K f(x_i | \hat{c} = k, c = l) P(\hat{c} = k, c = l) \end{aligned}$$

Semi-supervised CEM-algorithm

- CEM-algorithm using misclassified label

- Assume that the density of sample does not depends on its imperfect label given its true label :

$$f(x_i|\hat{c} = k, c = l) = f(x_i|c = l)$$

- Let $\alpha_{kl} = P(\hat{c} = k|c = l)$. Then, by Bayes rule,

$$f(x_i, \hat{c} = k) = p(x_i) \sum_{l=1}^K \alpha_{kl} P(c = l|x_i)$$

$$P(\hat{c} = k|x_i) = \sum_{l=1}^K \alpha_{kl} P(c = l|x_i)$$

Therefore, CML criterion is

$$L'_c = \sum_{i=1}^m \sum_{k=1}^K t_{ik} \log P(l = k|x_i) + \sum_{i=m+1}^n \sum_{k=1}^K z_{ik} \log \left(\sum_{l=1}^K \alpha_{kl} P(c = l|x_i) \right)$$

Semi-supervised CEM-algorithm

- CEM-algorithm using misclassified label : Example

► Example : [11] Lee, Porter (1984)

- Switching model :

$$y_t = x_t\beta + \delta I_t + \epsilon_t$$

- Misclassified label : w

$$P(I_t = 1) = \lambda$$

$$P(w_t = 1|I_t = 1) = p_{11}$$

$$P(w_t = 1|I_t = 0) = p_{01}$$

Semi-supervised CEM-algorithm

- CEM-algorithm using misclassified label : Example

- CLM criterion

$$\begin{aligned} L'_c &= \sum_{t=1}^T z_i \log f(y_t, w_t, I_t = 1) + (1 - z_i) \log f(y_t, w_t, I_t = 0) \\ &= \sum_{t=1}^T z_i \log f_1(y_t) (w_t p_{11} + (1 - w_t) p_{10}) \lambda \\ &\quad + (1 - z_i) \log f_0(y_t) (w_t p_{01} + (1 - w_t) p_{00}) (1 - \lambda) \end{aligned}$$

- Simulation result :

		n	100	500	1000	5000
CML	MSE		0.8113	0.4156	0.3626	0.3478
	Prob.mis.		0.0229	0.0139	0.0129	0.0128
ML	MSE		0.1773	0.0959	0.0635	0.0447
	Prob.mis.		0.0262	0.0216	0.0211	0.0208

$$\lambda = 0.1, \delta = -5, p_{11} = 0.6, p_{01} = 0.4, \beta = (1, 0.7)', \sigma = 1, x = [1, N(0, 1)]$$

Conclusion and future work

Conclusion and future work

- Conclusion

Which one is better? Mixture approach or CML?

1. [4] Celeux, Govaert (1993)'s Simulation result : comparing CML vs. ML.
2. Symons (1981) : "There seems to be no simple recommendation to guide the users of these criteria..."
3. [2] Bryant, Williamson (1978), [9] Ganesalingam (1989), ... : CML criterion produces biased estimates of the mixture parameters. This bias can be tolerable if the mixture components are well separated and the proportions are not too extreme. ML is preferable.

Conclusion and future work

- Another methods to use imperfect information of sample separation

- ▶ Non-parametric supervised classification methods with imperfect training data
 1. Nearest neighbor
 2. Bayes classifier : assign class to maximize conditional probability.
- ▶ Noise-robust methods : [12] Liu, Tao (2016)
- ▶ EM-algorithm for nonparametric mixing distribution : [15] Train (2008)

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